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DISPLACEMENT AND BLOCKING FORCE PERFORMANCE OF PIEZOELECTRIC T-BEAM ACTUATORS

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ABSTRACT

In this paper, we present the experimental validation of the detailed models developed for the flexural motion of piezoelectric T-beam actuators. With a T-shaped cross-section, and bottom and top flange and web electrodes, a cantilevered beam can bend in both in-plane and out-of-plane directions upon actuation. Analytical models predict the tip displacement and blocking force in both directions. Mechanical dicing and flange electrode deposition was used to fabricate six meso-scale T-beam prototypes. The T-beams were experimentally tested for in-plane and out-of-plane displacements, and out-of-plane blocking force. The analytical models closely predict the T-beam displacement and blocking force performance. A nondimensional analytical model predict that all T-beam designs for both in-plane and out-of-plane actuation, regardless of scale, have nondimensional displacement and blocking force equal to nondimensional voltage. The results from experiments are favorably compared with this theoretical prediction.

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1 INTRODUCTION

Piezoelectric actuators are used for many applications, including ultrasonic motors, micro-positioning systems, camera auto-focus lenses, structural vibration control, and control surfaces. Most piezoelectric actuators use lead zirconate titanate (PZT) because it provides large piezoelectric and electromechanical coupling factors. To produce reasonable motion, however, the 0.1% piezoelectric strain must be amplified. Stack actuators [1–3] produce larger motions by stacking electroded thin PZT disks and actuating through the thickness. In this case, the material poling, and applied voltage are in the same direction along the thickness for each block of the stack. Although, this makes use of the d_{33} piezoelectric coefficient which is approximately three times larger than the d_{31} coefficient used in unimorph or bimorph actuators, stack actuators with large number of layers are difficult to fabricate to produce reasonable displacements. In unimorph/bimorph actuators, two layers of material are separated by an electrode [3–6]. The unimorph has one PZT layer poled through the thickness and a passive layer. The PZT layer expands through the thickness and contracts longitudinally when an electric field is applied. The longitudinal contraction causes the unimorph to bend due to the constraining passive layer. The bimorph substitutes the passive layer with a second

active PZT layer. This produces maximum transverse displacement because each layer can be used with maximum applied field in the direction of poling. The maximum applied field in the direction opposite poling is limited to approximately one third of the coercive field to prevent depoling of the PZT. Tube actuators that produce bimorph actuation in two directions have been demonstrated at the macroscale [7] but are difficult to fabricate.

At the microscale, stack and uni/bimorph actuators are also difficult to fabricate. Although solder bonding techniques for PZT have been reported [8] stack actuators of more than a few layers have not been fabricated. Microscale actuators fabricated using AlN and ZnO [4, 9] thin films have poor performance due to the low piezoelectric coefficients of these materials. In comparison thin film PZT films exhibit much larger piezoelectric coefficients, however the quality of these films has been typically lower than of bulk PZT materials [10]. Only recently, advances in templated and textured growth of piezoelectric thin films have enabled achievement of piezoelectric coefficients in thin films that approach the values of their bulk counterparts. The challenges and opportunities relating to the integration of thin and bulk piezoelectric materials have been presented in a recent review [11]. Furthermore, the stress mismatch between the layers during the fabrication can result in variably deflected structures upon release. Thus, the performance of piezoelectric microactuators can be improved by developing novel designs that enable multidirectional displacement and provide easy fabrication by avoiding bonding of two layers.

In a previous paper we introduced the T-beam actuators [12] and developed out-of-plane models and performed preliminary optimization studies. This paper describes the in-plane and out-of-plane modeling, design, fabrication, and testing of meso-scale prototypes that are diced from bulk PZT. In this paper, we present the experimental measurements of out-of-plane and in-plane displacements and out-of-plane blocking force. The experimental results are compared with the theoretical predictions.

2 THE T-BEAM ACTUATOR CONCEPT

The design of a cantilevered T-beam actuator is shown in Fig. 1. The entire T-beam is PZT with electrodes deposited on the top of the web, the top of each flange, and the bottom of the flange. The PZT is poled through-the-thickness from top to bottom.

Fig. 1 shows that the T-beam actuator can be bent both in-plane and out-of-plane by selectively activating the various electrodes. The bottom electrode acts as a ground. Out-of-plane motion can be achieved by applying voltage to the web electrode or to both flange electrodes. Application of voltage to the web electrode causes the web to expand through the thickness and contracts longitudinally (d_{31} piezoelectric effect). The inactive flange constrains the lower part of the T-beam, acting as the passive layer in a unimorph design, and the beam bends up-

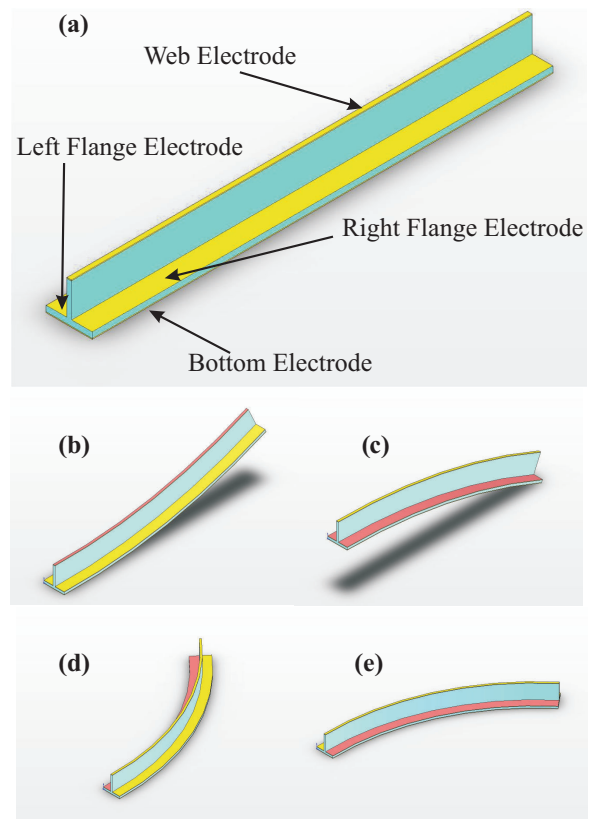


Figure 1. T-beam actuator concept: (a) As fabricated and deflected shapes when voltage is applied between (b) both flanges and bottom electrodes, (c) web and bottom electrode, (d) left flange and bottom electrode, and (e) right flange and bottom electrode.

ward (see Fig. 1(b)). Alternatively, the two flanges contract due to flange actuation, the web resists contraction, and the T-beam bends downward (see Fig. 1(c)).

The T-beam can also provide in-plane displacement by differential application of voltage to the two flanges. For in-plane bending the left and right flange electrodes are actuated to produce left and right bending as shown in Figs. 1(d) and 1(e), respectively. Left and right flange actuation also cause some downward out-of-plane deflection. The T-beam actuator thus eliminates bonding of two layers as in a unimorph though multiple electrodes are needed to actuate the T-beam.

3 ANALYTICAL MODELING

To understand the physical behavior of the T-beam actuator and optimize its performance we develop a physics based model that predicts out-of-plane and in-plane displacement and blocking force. The T-beam actuator with the web and flange elec-

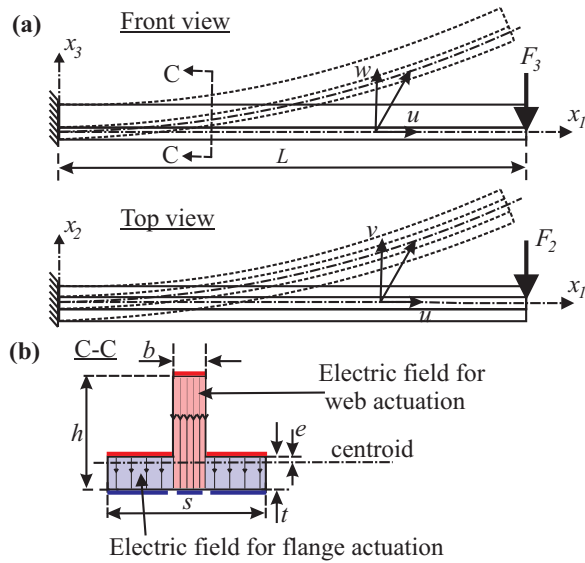


Figure 2. T-beam model: (a) the initial and deflected shape (out-of-plane (top) and in-plane (bottom)) and (b) cross section.

trodes shown in Fig. 2 is modeled as a cantilever beam using Euler-Bernoulli beam theory and assuming uniform electric field through the thickness. Fig. 2(a) shows a schematic of the initial and deflected shapes of the T-beam actuator in both out-of-plane (top) and in-plane (bottom) directions. The beam is assumed to be initially straight and lying along the longitudinal x_1 axis. F_2 and F_3 are the horizontal (in-plane) and vertical (out-of-plane) loads passing through the shear center of beam such that they do not cause twist. The variables u , v and w denote the displacements in the longitudinal (x_1), transverse in-plane (x_2) and transverse out-of-plane (x_3) directions, respectively. The cross-section of the T-beam shown in Fig. 2(b) has a flange width s , flange thickness t , web width b , and overall height h . The longitudinal axis runs through the centroid of the T-beam cross section, halfway through the cross section in the x_3 direction and through the centroid at a distance

$$e = \frac{1}{2} \frac{t^2 s - t^2 b + 2 t b h - b h^2}{t s - t b + b h} \quad (1)$$

below the top of the flange. As shown in Fig. 2(b), the bottom electrode is subdivided into three regions under the right and left flanges and the web. For upward out-of-plane actuation, voltage, V is applied between the web and the middle electrode on the bottom of the flange. Voltage applied between right or left flange electrodes and the corresponding outer electrode on the bottom of the flange produces in-plane motion. We assume uniform and constant electric field along the x_3 axis through the

thickness of actuator as shown in Fig. 2(b). For flange actuation, $V = (\phi_{\text{flange}} - \phi_{\text{bottom}})/t$ and we neglect the field in the web. For web actuation $V = (\phi_{\text{web}} - \phi_{\text{bottom}})/h$ and we neglect the field in the flanges.

The governing equations are obtained using the principle of virtual work. The potential energy of the T-beam actuator is

$$U_b = \int_{V_b} \frac{E}{2} (u' - x_2 v'' - x_3 w'')^2 dV, \quad (2)$$

$$U_p = \int_{V_p} H dV, U = U_b + U_p,$$

where $(\cdot)' = \frac{d(\cdot)}{dx_1}$, E is the Young's modulus of PZT-4, U_b and U_p are the potential energy of the passive region and active region, respectively, and U is the total potential energy.

The electric enthalpy H for the active piezoelectric material, obtained from piezoelectric constitutive equations [5, 12] and electric boundary conditions is given by

$$H = \frac{E}{2} (u'')^2 + \frac{E}{2} x_2^2 (v'')^2 - E x_2 u' v'' + (a_2 x_3^2 + a_3) (w'')^2 + a_4 V w'' + a_5 V^2 + (a_6 + a_7 x_3) w'' u' - (a_7 x_2 x_3 + a_6 x_2) w'' v'' + a_8 V u' - a_8 V x_2 v'', \quad (3)$$

where $e_{31} = E d_{31}$ is piezo-electric stress coefficient, and $\epsilon_{33} = K_{33} \epsilon_0$ is the permittivity of PZT [5]. The coefficients in Eq. (3) are given in Table 1 for web and flange actuation and ϵ_{33} is the permittivity of PZT, $e_{31} = E d_{31}$ is the piezoelectric stress coefficient, where, d_{31} is the piezoelectric strain coefficient.

Substitution of Eqs. (2) into the principal of virtual work, $\int_0^L (\delta U + F_2 \delta v(L) + F_3 \delta w(L)) dt = 0$, produces the field equations

$$\frac{d^4 w(x_1)}{dx_1^4} = 0, \frac{d^4 v(x_1)}{dx_1^4} = 0, \frac{d^2 u(x_1)}{dx_1^2} = 0, \forall x \in (0, L), \quad (4)$$

geometric boundary conditions at the fixed end

$$u(0) = 0, v(0) = 0, w(0) = 0, \frac{dv(0)}{dx} = 0, \frac{dw(0)}{dx} = 0, \quad (5)$$

Table 1. Electromechanical coefficients for web and flange actuation

Coefficient	Web	Flange
a_2	$\frac{1}{2} \left(E + \frac{e_{31}^2}{\epsilon_{33}} \right)$	$\frac{1}{2} \left(E + \frac{e_{31}^2}{\epsilon_{33}} \right)$
a_3	$-\frac{e_{31}^2(2e+h-2t)^2}{8\epsilon_{33}}$	$-\frac{e_{31}^2(2e-t)^2}{8\epsilon_{33}}$
a_4	$-\frac{e_{31}(2e+h-2t)}{2h}$	$-\frac{e_{31}(2e-t)}{2t}$
a_5	$\frac{-\epsilon_{33}}{2h^2}$	$\frac{-\epsilon_{33}}{2t^2}$
a_6	$\frac{e_{31}^2}{2\epsilon_{33}}(2e+h-2t)$	$\frac{e_{31}^2}{2\epsilon_{33}}(2e-t)$
a_7	$-\frac{E\epsilon_{33}+e_{31}^2}{\epsilon_{33}}$	$-\frac{E\epsilon_{33}+e_{31}^2}{\epsilon_{33}}$
a_8	$\frac{e_{31}}{2h}$	$\frac{e_{31}}{2t}$

and the natural boundary conditions at the free end

$$\begin{aligned}
 E(A_b + A_p) \frac{du(L)}{dx} + a_8 A_p V &= 0, \\
 E(I_{p2} + I_{b2}) \frac{d^2v(L)}{dx_1^2} - a_8 A_p V &= 0, \\
 E(I_{p2} + I_{b2}) \frac{d^3v(L)}{dx_1^3} - F_2 &= 0, \\
 (EI_{b3} + 2a_2 I_{p3} + 2a_3 A_p) \frac{d^3w(L)}{dx_1^3} - F_3 &= 0, \\
 (EI_{b3} + 2a_2 I_{p3} + 2a_3 A_p) \frac{d^2w(L)}{dx_1^3} + a_4 A_p V &= 0,
 \end{aligned} \tag{6}$$

where (A_p, A_b) , (A_{p2}, A_{b2}) , (I_{p2}, I_{b2}) , and (I_{p3}, I_{b3}) are the cross-sectional area, first moment of area, and second moment of area of the active and passive regions, respectively, about the neutral axis as given in Tab. 2.

The solutions of Eqs. (4) are

$$\begin{aligned}
 u(x_1) &= b_1 x_1 + b_0, \\
 v(x_1) &= c_3 x_1^3 + c_2 x_1^2 + c_1 x_1 + c_0, \\
 w(x_1) &= d_3 x_1^3 + d_2 x_1^2 + d_1 x_1 + d_0.
 \end{aligned} \tag{7}$$

The 10 unknown coefficients b_j , c_i , d_i are solved analytically using the 10 boundary conditions to obtain

$$\begin{aligned}
 w(x_1) &= \frac{-(LF_3 + a_4 V A_p) x_1^2}{2(2a_2 I_{p3} + 2a_3 A_p + E_p I_{b3})} \\
 &\quad + \frac{F_3 x_1^3}{6(2a_2 I_{p3} + 2a_3 A_p + E_p I_{b3})}, \\
 v(x_1) &= \frac{(-LF_2 + a_8 V A_{p2}) x_1^2}{2E_p (I_{p2} + I_{b2})} + \frac{F_2 x_1^3}{6E_p (I_{p2} + I_{b2})}.
 \end{aligned} \tag{8}$$

The tip displacements obtained by substituting $x_1 = L$ in Eq. (8) are

$$\begin{aligned}
 v(L) &= -\frac{L^3 F_2}{3E_p (I_{p2} + I_{b2})} + \frac{a_8 A_{p2} L^2 V}{2E_p (I_{p2} + I_{b2})}, \\
 w(L) &= -\frac{L^3 F_3}{3(2a_2 I_{p3} + 2a_3 A_p + E_p I_{b3})} \\
 &\quad - \frac{a_4 A_p L^2 V}{2(2a_2 I_{p3} + 2a_3 A_p + E_p I_{b3})}.
 \end{aligned} \tag{9}$$

The free tip displacements, v_f and w_f , defined as the displacement at the tip of actuator when the applied force F_2 and F_3 equal to zero are

$$\begin{aligned}
 v_f &= \frac{a_8 A_{p2} L^2 V}{2E_p (I_{p2} + I_{b2})}, \\
 w_f &= -\frac{a_4 A_p L^2 V}{2(2a_2 I_{p3} + 2a_3 A_p + E_p I_{b3})},
 \end{aligned} \tag{10}$$

where $F_2 = F_3 = 0$ in Eq. (9). The blocking forces,

$$\begin{aligned}
 F_{2b} &= \frac{3a_8 A_{p2} V}{2L}, \\
 F_{3b} &= -\frac{3a_4 A_p V}{2L}
 \end{aligned} \tag{11}$$

constrain the tip displacements $v(L) = w(L) = 0$ in Eq. (9).

3.1 Nondimensional modeling

We reduce the parametric model to a simple linear relationship between the nondimensional voltage and the nondimensional displacements and blocking forces. In this way, all of the obtained experimental data can be shown on one plot, regardless of the device parameters. The nondimensional (starred) parameters

$$x_1^* = \frac{x_1}{L}, w^* = \frac{w}{L}, v^* = \frac{v}{L}, \tag{12}$$

Table 2. Cross-sectional area, first moment of area, and second moment of area for web, flange and, single flange actuation

Constant	Web	Flange	Single flange
A_b	$t(s-b)$	bh	$\frac{(2h-t)b+st}{2}$
A_p	bh	$t(s-b)$	$\frac{(s-b)t}{2}$
A_{p2}	0	0	$\frac{t(s^2-b^2)}{8}$
I_{b2}	$\frac{t}{12}(s^3-b^3)$	$\frac{b^3h}{12}$	$\frac{(2h-t)b^3+s^3t}{24}$
I_{p2}	$\frac{b^3h}{12}$	$\frac{t}{12}(s^3-b^3)$	$\frac{t(s^3-b^3)}{24}$
I_{b3}	$\frac{(s-b)t^3}{12}$ $+A_b\left(e-\frac{t}{2}\right)^2$	$\frac{bh^3}{12}$ $+A_b\left(e-t+\frac{h}{2}\right)^2$	$I_{p3}+\frac{bh^3}{12}$ $+bh\left(e-t+\frac{h}{2}\right)^2$
I_{p3}	$\frac{bh^3}{12}$ $+A_p\left(e-t+\frac{h}{2}\right)^2$	$\frac{(s-b)t^3}{12}$ $+A_p\left(e-\frac{t}{2}\right)^2$	$\frac{(s-b)t^3}{24}$ $+A_p\left(e-\frac{t}{2}\right)^2$

are introduced into Eq. 4 to produce

$$w^*(1) = F_3^* + V_3^*, v^*(1) = F_2^* + V_2^*, \quad (13)$$

where the nondimensional forces and voltages in the out-of-plane and in-plane directions are

$$F_2^* = -\frac{\kappa}{3\gamma}, F_3^* = -\frac{\beta}{3\alpha}, V_2^* = -\frac{\psi}{2\gamma}, V_3^* = -\frac{\tau}{2\alpha}, \quad (14)$$

with the parameters

$$\alpha = 1 + \frac{2a_2I_{p3}}{EI_{b3}} + \frac{2a_3A_p}{EI_{b3}}, \beta = \frac{F_3L^2}{EI_{b3}}, \tau = \frac{a_4VA_pL}{EI_{b3}}, \quad (15)$$

$$\gamma = 1 + \frac{I_{p2}}{I_{b2}}, \kappa = \frac{F_2L^2}{EI_{b2}}, \psi = -\frac{a_8VA_{p2}L}{EI_{b2}},$$

From Eq. (13) the nondimensional free tip displacements

$$v_f^* = V_2^*, w_f^* = V_3^*, \quad (16)$$

and the non-dimensional blocking forces

$$F_{2b}^* = -V_2^*, F_{3b}^* = -V_3^*. \quad (17)$$

4 FABRICATION PROCESS

A schematic illustration of the T-beam fabrication process using a precision dicing saw and photolithography is shown in Fig. 3. A K & S Model 980 precision dicing saw defines web regions on a finely polished 25.4 mm X 25.4 mm X 1 mm PZT-4 substrate which has been electroded with a layer of Cr/Au shown in Fig. 3(a-b). The saw uses a 100 μ m Nickel blade coated with 3-6 μ m diamond grit. Figure 3(c) shows the bottom electrodes patterned and etched using photolithography and wet etching. The high aspect ratio T-beams are spray coated with Shipley 1805 photoresist, and the flange electrodes are then aligned

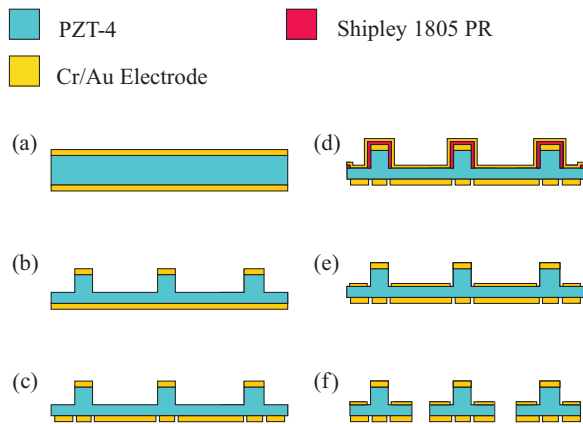


Figure 3. Schematic illustration of T-beam fabrication: (a) start with 1mm thick bulk PZT-4 with Cr/Au coating, (b) dice to form web regions, (c) etch bottom electrodes, (d) spray photoresist pattern and evaporate Cr/Au for flange electrodes, (e) lift-off photoresist to form flange electrodes, (f) release individual T-beams by dicing.

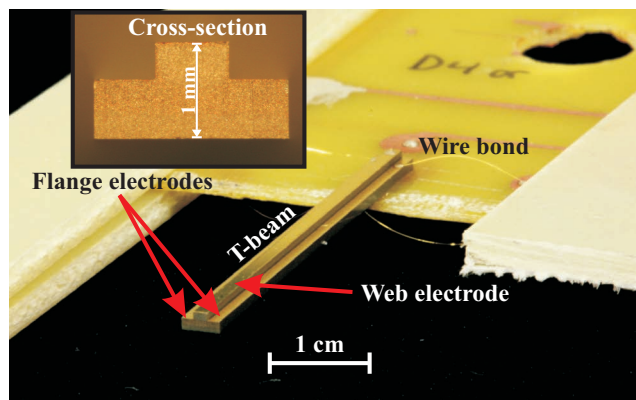


Figure 4. Photograph of a fabricated and mounted T-beam (Device 4) actuator.

and patterned. A layer of 15 nm Cr and 150 nm Au is vacuum evaporated onto the substrate using a planetary sample holder on an electron beam evaporator with a MDC Mighty Source™ as shown in Fig. 3(d). An ultrasonic acetone bath was used to perform the liftoff procedure removing photoresist and gold from the undesired areas as shown in Fig. 3(e). The T-beams were finally released by dicing (see Fig. 3(f)). The T-Beams are then packaged onto custom designed PCBs and wire bonded using a K&S Model 4524 wire bonding machine. In total, 6 independent electrodes (3 on top and 3 on bottom) enable actuation of the T-beam in both out-of-plane and in-plane directions. The web regions and flange regions have identical polarization which al-

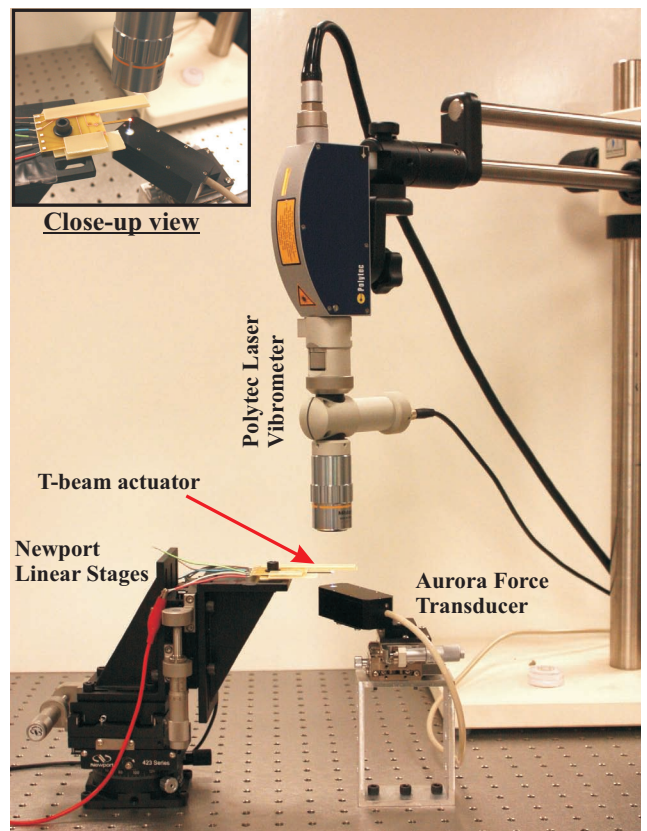


Figure 5. Photograph of experimental set-up to measure displacement and blocking force of T-beam actuators.

lows actuation using one high voltage amplifier and appropriate circuitry.

5 PROTOTYPING AND EXPERIMENTAL SETUP

Six devices are built with the different configurations as listed in Tab. 3. Five of the devices have different flange thicknesses and approximately same length and web width except for first one which had its tip broken off during fabrication. Figure 4 shows the picture of fabricated and mounted Device 4. The inset zooms in on the cross-section of T-beam at the tip. The 0.8 mm thick FR4 circuit board is attached along its edges to a thicker 1.6 mm FR4 base which then is attached to linear stages that allow precise positioning of the actuator. High resolution pictures of the cross-section, top-view, and bottom view of each device were used to measure the various geometric parameters with a precision of approximately $\pm 20 \mu\text{m}$ in cross-sectional dimensions and $\pm 50 \mu\text{m}$ in length. The material properties of PZT-4 used for the fabricated T-beams are given in Tab. 4.

Table 3. Fabricated prototype parameters

Device	Length L (mm)	Total width s (μm)	Flange thickness t (μm)	Height h (μm)	Web width b (μm)
1	14.6	2012	134	1000	765
2	20.4	2008	298	1000	774
3	20.1	2000	417	1000	764
4	20.4	1993	612	1000	756
5	21.3	2017	788	1000	770
6	20.7	1995	320	1000	512

Table 4. PZT-4 material properties

Description	
Youngs modulus of PZT, E (GPa)	78
Piezoelectric strain coefficient, d_{31} (C/N)	-122e-12
Permittivity of PZT, ϵ_{33} ($\text{C}^2/(\text{Nm}^2)$)	1.15e-08

The experimental setup used to measure the displacement and blocking force of the actuators is shown in figure 5. A model OFV5000 Polytec laser vibrometer controller with OFV534 sensor head measures the displacement with a measuring spot size of $20 \mu\text{m}$. A 3-axis Newport linear stage with micrometer screws accurately positions the T-beam so that the laser is precisely focused at the desired location. An Aurora 402A force transducer with a 1 mm diameter glass tube sensing tip was used to measure the blocking force. The force transducer has a resolution of $10 \mu\text{N}$ and can measure up to $\pm 500 \text{ mN}$. The force transducer was mounted on two Aurora linear stages to allow positioning the sensor tip at the desired location on the T-beam. A model 609E-6 Trek amplifier generates the desired voltages for actuating the T-beams.

6 EXPERIMENTAL TESTING AND VALIDATION

The six independent electrical connections on the fabricated T-beams enable web, flange, right flange or left flange actuation to produce out-of-plane and in-plane motions. Blocking force measurements are performed only for web and flange actuations due to the difficulty in measuring transverse forces.

A triangle wave signal at 1 Hz frequency (total 10 cycles) was used to actuate the T-beam such that the electric field ϕ is

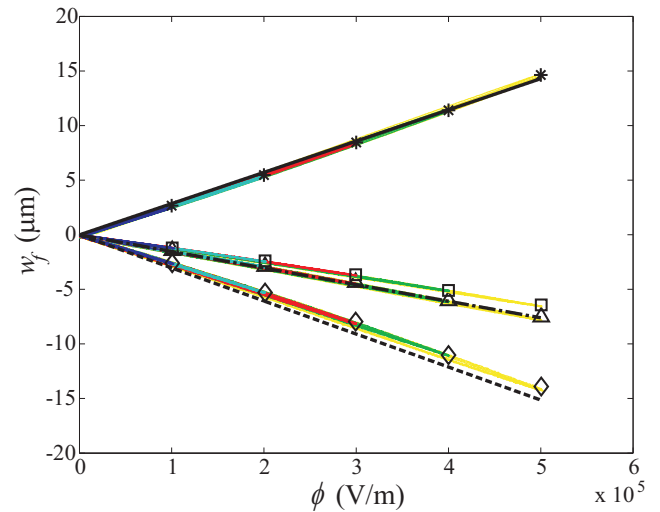


Figure 6. Free tip out-of-plane displacement w_f versus applied electric field ϕ versus for Device 3: Theoretical (solid - web actuation, dashed - flange actuation, dashdot - right or left flange actuation) and experimental (star - web actuation, diamond - flange actuation, square - left flange, and triangle - right flange).

always in the direction of poling. The experiment was repeated for peak electric fields of 0.1, 0.2, 0.3, 0.4, 0.5 $\text{V}/\mu\text{m}$ for both displacement and blocking force measurements. The peak voltage applied was $V = \phi h$ for web actuation and $V = \phi t$ for flange actuation and the un-actuated electrodes were allowed to float. To account for the compliance of force sensor and FR4 mounting, displacement measurements were taken at the tip and base of the T-beam actuator during blocking force measurements.

Figure 6 shows the out-of-plane free tip displacements w_f of device 3 for different actuations. The yellow, green, red, cyan blue colored lines are the experimental data under triangle wave excitation for applied electric field of 0.5, 0.4, 0.3, 0.2, 0.1 $\text{V}/\mu\text{m}$, and the symbols are averages over 10 cycles. Similarly, Fig. 7 shows the experimental and analytical in-plane free tip displacement v_f versus applied electric field ϕ . The data shows that the analytical predictions closely match the displacement magnitude and trend for the T-beam actuator. The experimental T-beams are not rigidly clamped at the base because the FR4 circuit board is thinner and softer than the T-beam. The electrodes extend all the way to the end of the beam. Sixty percent of the "clamped" region is included in the beam length to model this effect. The experimental displacements show a linear relationship with the applied field. Web and both flange actuation produce similar displacements in opposite directions. Single flange actuation produces less out-of-plane displacement and, as expected, the left and right flange actuation cases produce similar displacements.

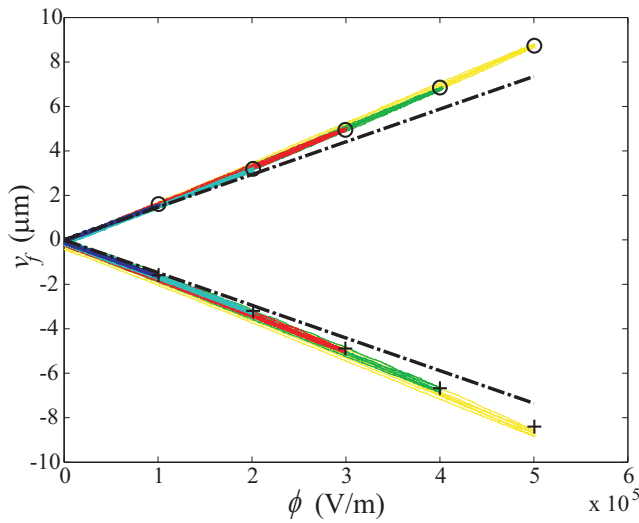


Figure 7. In-plane tip displacement, v_f versus applied electric field, ϕ for Device 3: theoretical (dashdot - Right flange (top), left flange (bottom)) and experimental (plus - left flange, circle - right flange).

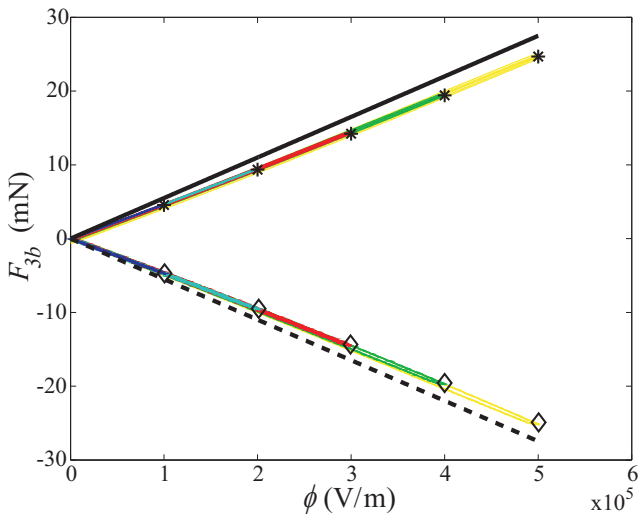


Figure 8. Tip force, F_3 versus applied electric field ϕ for Device 3: Theoretical (solid - web actuation, dashed - flange actuation) and experimental (star - web actuation, diamond - flange actuation).

The compliance of the FR4 circuit board also affected the blocking force measurements. As a result, perfect clamped boundary conditions are not realized. Accordingly, the experi-

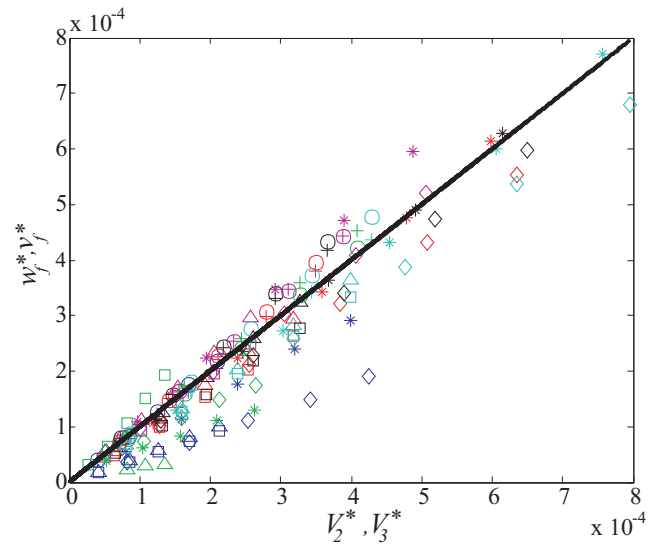


Figure 9. Non-dimensional displacement, v_f^* , w_f^* versus non-dimensional voltage, V_2^* , V_3^* for Devices 1 - 6: Theoretical (solid) and experimental (star - web actuation, diamond - flange actuation, square or plus - left flange, triangle or circle - right flange actuation).

mental blocking force is

$$(F_{3b})_{\text{exp}} = (F_3)_{\text{exp}} + \frac{3(2a_2I_{p3} + 2a_3A_p + E_pI_{b3})w_{\text{exp}}}{L^3}, \quad (18)$$

where, w_{exp} is the measured displacement of T-beam with tip force. Figure 8 shows the experimental and theoretical out-of-plane blocking force for web and flange actuation. The analytical model predicts the trend accurately but slightly overpredicts the magnitude. The results are linear with applied field and the web and flange actuation produce similar blocking forces at similar field. It should be noted, however, that flange actuation uses less voltage because the flange is thinner than the web.

Figure 9 shows the nondimensional analytical and experimental displacements v_f^* , w_f^* versus nondimensional voltage V_2^* and V_3^* for Devices 1 - 6. Nondimensionalization allows the in-plane and out-of-plane displacement results for all the devices in all actuation modes to be plotted against the one theoretical line. Different symbols denote different types of actuation and each color represents a different device. From the plot, it can be seen, that the analytical model in general closely predicts the trend and magnitude of all the devices. A linear fit to the data has a slope of 43.3° , within 3.8% of the analytical slope of 45° . The 95% confidence interval has a lower limit of 42.5° and an upper limit of 44.1° . Device-1 (blue) has inferior flange electrodes that produce poor performance in flange actuation. Device 4 (magenta)

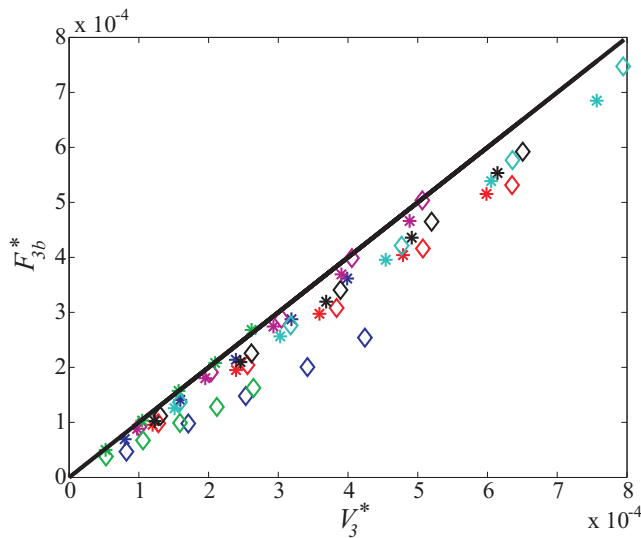


Figure 10. Non-dimensional blocking force F_{3b}^* versus nondimensional voltage V_3^* for Devices 1 to 6: Theoretical (solid) and experimental (star-web actuation, diamond - flange actuation).

in web actuation, however, produced higher displacements than predicted by theory.

Figure 10 shows the dimensionless blocking force F_{3b}^* for Devices 1 - 6 versus dimensionless voltage V_3^* . The best fit line for the experimental data has a slope of 41.2° , within 8% of the theoretical slope of 45° . The 95% confidence interval of slope has a lower limit of 40.5° and an upper limit of 41.9° . Again, the flange actuation cases slightly underperform web actuation, probably due to incomplete coverage of the flanges by the deposited electrodes.

7 FUTURE WORK

The analytical model developed closely predicts the T-beam performance. We plan to use this analytical model to optimize the displacement and blocking force performance of T-beam actuators. Also, we plan to compare its optimized performance with the state of the art actuators like unimorph actuator. Furthermore, T-beams are to be studied for dynamic response.

8 CONCLUSIONS

In this paper, an analytical model is developed that predicts displacement and blocking force in both in-plane and out-of-plane directions. Six T-beam prototypes are built using mechanical dicing and electrode deposition and experimentally tested for in-plane and out-of-plane displacement and out-of-plane blocking force. Analytical models closely predict the T-beam displace-

ment and blocking force performance.

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